## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/584,102	SCHEUCHER, HEIMO

10/584,102 Examiner

CHRIS C. CHU

Art Unit

SEARCHED						
Class	Subclass	Date	Examiner			
257	E21.524, E23.179, 797 & 48	2/18/2008	C.C.			
257	238 & 68	2/18/2008	C.C.			
257	620	2/18/2008	C.C.			
430	22 & 5	2/18/2008	C.C.			
430	311	2/18/2008	C.C.			
324	633 & 765	2/18/2008	C.C.			
324	754	2/18/2008	C.C.			
356	399	2/18/2008	C.C.			
			-			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			-
			-

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
Searched in US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; and IBM_TDB;	2/18/2008	C.C.		